



Support & training



OPA593 SBOS659 - JANUARY 2022

OPA593 85-V, 250-mA Output Current, Precision Operational Amplifier

1 Features

- Low offset voltage: ±10 µV
- Low offset voltage drift: ±0.4 µV/°C
- High output current: 250 mA
- Low noise: 6 nV/ \sqrt{Hz} at 10 kHz •
- Rail-to-rail output
- Wide bandwidth: 10-MHz GBW
- High slew rate: 40 V/µs
- Wide supply: ±5 V to ±42.5 V, 10 V to 85 V ٠
- Quiescent current: 3.25 mA
- Current limit accurate to 10%
- **Disable function** •
- Overtemperature and overcurrent flags
- Temperature range: -40°C to +125°C
- Available in WSON package

2 Applications

- Semiconductor test •
- Semiconductor manufacturing
- DC power supply, AC source, electronic load
- LCD test

3 Description

The OPA593 is a high-voltage (85 V), wide bandwidth (10 MHz), high-output-current (250 mA), unity-gainstable operational amplifier.

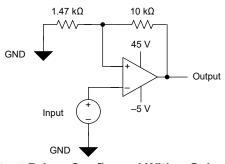
The OPA593 uses a laser trimming technique to improve the offset voltage $(10 \,\mu V)$ and offset voltage drift ($0.4 \,\mu V/^{\circ}C$), thus avoiding the need for calibration. An external resistor can be used to limit the current (±10% accuracy), thus providing more precise measurements. In case of an overcurrent or overtemperature condition, the device indicates erroneous operation through a status flag. An included disable feature can be used to shutdown the device, saving power and placing the output into a high-impedance state.

The device is unity-gain stable, enabling operation as a high-impedance buffer, while the wide bandwidth (10 MHz) and high slew (40 V/µs) enable high signal gains. The high output current and capacitive drive allow the device to drive external FETs used to provide higher system currents, such as in a digital power supply.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	BODY SIZE (NOM)
OPA593	WSON (12)	4.00 mm × 4.00 mm

(1)For all available packages, see the package option addendum at the end of the data sheet.



Output Driver Configured With a Gain of 8

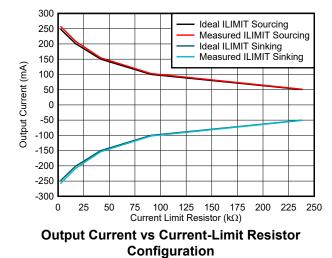




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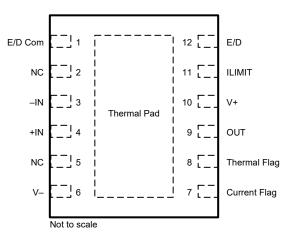
4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
January 2022	*	Initial Release



5 Pin Configuration and Functions



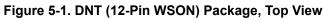


Table 5-1. Pin Functions

PIN NAME NO.		TYPE	DESCRIPTION
		TTPE	DESCRIPTION
Current Flag	7	Output	Overcurrent status flag
E/D	12	Input	Enable and disable
E/D Com	1	Input	Enable and disable common
ILIMIT	11	Input	Current limit
+IN	4	Input	Noninverting input
-IN	3	Input	Inverting input
NC	2, 5	_	No internal connection
OUT	9	Output	Output
Thermal Flag	8	Output	Overtemperature status flag
Thermal Pad	Thermal pad	_	The thermal pad is internally connected to V–. The thermal pad must be soldered to a printed-circuit board (PCB) connected to V–, even with applications that have low power dissipation.
V+	10	Power	Positive (highest) power supply
V-	6	Power	Negative (lowest) power supply

6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
Vs	Supply voltage, $V_S = (V+) - (V-)$		93	V
	Signal input pin voltage ⁽²⁾	(V–) – 0.1	(V+) + 0.1	V
	E/D to E/D Com pin voltage		5.5	V
	ILIMIT pin voltage	V-	(V–) + 3.35	V
	All input pins current ⁽²⁾		±10	mA
	Output short circuit current ⁽³⁾		Continuous	
T _A	Operating temperature	-55	125	°C
TJ	Junction temperature		150	°C
T _{STG}	Storage temperature	-55	125	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) Input pins, Status Flag, E/D, and E/D Com, and Output are diode-clamped to the power-supply rails. Input signals that can swing more than 0.3 V beyond the supply rails must be current-limited to 10 mA or less.

(3) Short-circuit to ground.

6.2 ESD Ratings

				VALUE	UNIT
	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V		
	V(ESD)	Electrostatic discharge	Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 ⁽²⁾	±500	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

			MIN	NOM MAX	UNIT
$\mathbf{Y} = \mathbf{S}_{\text{transferred}} \mathbf{Y} = (\mathbf{Y}_{\text{transferred}} \mathbf{Y}_{\text{transferred}} \mathbf{Y}_$		Single supply voltage	10	85	V
Supply voltage, V _S	Supply voltage, $V_S = (V+) - (V-)$	Dual supply voltage	±5	±42.5	v
T _A	Operating temperature		-40	125	°C

6.4 Thermal Information

		OPA593	
	THERMAL METRIC ⁽¹⁾	DNT (WSON)	UNIT
		12 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	40.8	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	30.2	°C/W
R _{θJB}	Junction-to-board thermal resistance	17.8	°C/W
ΨJT	Junction-to-top characterization parameter	0.3	°C/W
Ψјв	Junction-to-board characterization parameter	17.7	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	4.3	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.



6.5 Electrical Characteristics

at $V_S = \pm 42.5$ V, $T_A = 25^{\circ}$ C, $R_L = 10$ k Ω to mid-supply, and $V_{CM} = V_{OUT}$ = mid-supply (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFFSET	VOLTAGE	· · ·				
V _{OS}	Input offset voltage			±10	±100	μV
dV _{OS} /dT	Input offset voltage drift	$T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C$		±0.4	±2	μV/°C
PSRR	Power supply rejection ratio	$V_{S} = \pm 4 V \text{ to } \pm 42.5 V$		1	5	μV/V
INPUT B	IAS CURRENT					
		T _A = 25°C		10	20	
IB	Input bias current	$T_A = -40^{\circ}C$ to +85°C			500	pА
		$T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C$			1	nA
				10	20	
l _{os}	Input offset current	$T_A = -40^{\circ}C$ to $+85^{\circ}C$			500	pА
		$T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C$			1	nA
NOISE						
	Input voltage noise	f = 0.01 Hz to 10 Hz		2.5		μV _{PP}
	······································	f = 10 Hz		80		F.FF
e _n	Input voltage noise density	f = 1 kHz		8		nV/√ Hz
		f = 10 kHz		6		
i _n	Current noise density	f = 1 kHz		2		fA/√ Hz
				E		0.0.012
V _{CM}	Common-mode voltage	Linear operation	(V–) – 0.1		(V+) – 3.5	V
V CM		$(V-) \le V_{CM} \le (V+) - 3.5 V$	130	140	(v) = 0.0	v
CMRR	Common-mode rejection	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C,$	150	140		dB
		$(V_{-}) \le V_{CM} \le (V_{+}) - 3.5 V$	110	120		
INPUT IN	IPEDANCE					
	Differential			10 ¹³ 0.3		Ω pF
	Common-mode			10 ¹³ 9.4		Ω pF
OPEN-LC						
		$(V-) + 0.3 V < V_O < (V+) - 0.3 V,$ $R_L = 10 k\Omega, T_A = +25^{\circ}C$	135	140		
		$(V-) + 0.3 V < V_O < (V+) - 0.3 V,$ $R_L = 10 k\Omega, T_A = -40^{\circ}C to +125^{\circ}C$	120	140		
•		$(V-) + 1 V < V_O < (V+) - 1 V,$ $R_L = 2 k\Omega, T_A = +25^{\circ}C$	110	130		dB
A _{OL}	Open-loop voltage gain	$(V-) + 1 V < V_0 < (V+) - 1 V,$ $R_L = 2 k\Omega, T_A = -40^{\circ}C \text{ to } +125^{\circ}C$	110	130		uВ
		$ (V-) + 2.5 V < V_O < (V+) - 2.5 V, \\ R_L = 600 \ \Omega, \ T_A = +25^{\circ}C $	100	120		
		(V-) + 2.5 V < V _O < $(V+)$ – 2.5 V, R _L = 600 Ω , T _A = -40°C to +125°C	100	120		
FREQUE	NCY RESPONSE					
GBW	Gain-bandwidth product			10		MHz
SR	Slew rate	Gain = ± 1 , V _O = 70-V step		40		V/µs
t-	Settling time	To ±0.1%, gain = –1, V _O = 70-V step, C _L = 100 pF		0.75		110
t _S	Settling time	To ±0.01%, gain = –1, V _O = 70-V step, C _L = 100 pF		1.5		μs
THD+N	Total harmonic distortion + noise	Gain = +1, V _O = 70 V _{PP} f = 1 kHz, R _L = 600 Ω		-105		dB
THD+N		Gain = +1, V_O = 70 V_{PP} f = 1 kHz, R_L = 2 k Ω		-110		uD



6.5 Electrical Characteristics (continued)

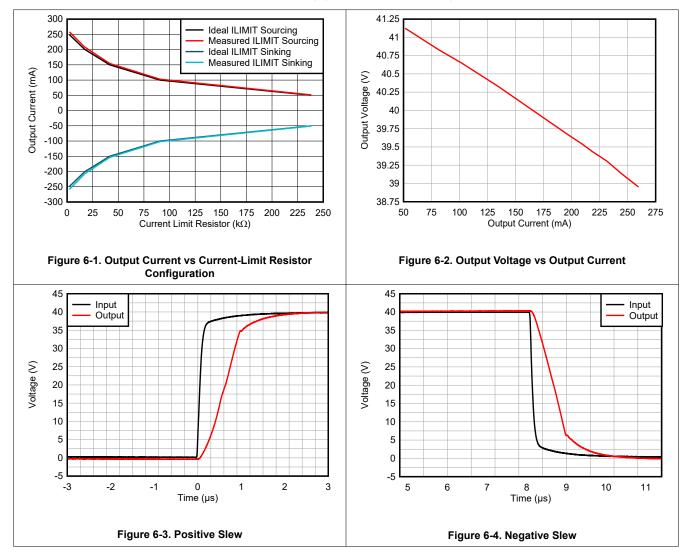
at V_S = ±42.5 V, T_A = 25°C, R_L = 10 k Ω to mid-supply, and V_{CM} = V_{OUT} = mid-supply (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OUTPU	т					
		No load		10	25	
		I _{OUT} = 50 mA		50	125	mV
Vo	Voltage output swing from rail	I _{OUT} = 100 mA		400	750	
		I _{OUT} = 250 mA		1.2	2	V
	Continuous output current, dc	V _S = ±42.5 V	200	250		mA
CLOAD	Capacitive load drive		See t	ypical curves		pF
Zo	Open-loop output impedance		See t	ypical curves		Ω
	Output impedance	Output disabled		TBD		Ω
	Output capacitance	Output disabled		TBD		pF
CURRE						
ILIMIT	Current limit		-250		+250	mA
		25 mA ≤ I _{OUT} ≤ 50 mA			10	
	Current limit accuracy	50 mA ≤ I _{OUT} ≤ 250 mA			5	%
	Current limit equation	R _{CL} connected between ILMIT pin and V– pin supply	(3.687 V * 40	00) / (56.7 kΩ	+ R _{CL})	
STATUS	S FLAG PIN (Referenced to E/D Com)					
		Overcurrent delay		10		
		Overcurrent recovery delay		10		
	Status Flag delay	Overtemperature delay		10		μs
		Overtemperature recovery delay		10		
		Alarm (status flag high)		170		
	Thermal shutdown	Return to normal operation (status flag low)		150		°C
	Status flag output voltage	Normal operation	See t	ypical curves		
E/D (EN	IABLE/DISABLE) PIN					
	Output enable voltage	Pin open or forced high	E/D Com + 2.5		E/D Com + 5	V
V _{E/D}	Output disable voltage	Pin forced low	E/D Com		E/D Com + 0.65	V
Ι _Ε	Enable input current			50		μA
	Output disable time			10		μs
	Output enable time			10		μs
E/D CO	M PIN		1			
	E/D Com pin voltage		(V–)		(V+) – 6	V
POWEF	SUPPLY	I	1			
				3.25	3.75	
l _Q	Quiescent current	$T_A = -40^{\circ}C$ to $+125^{\circ}C$			4	mA
. U		Output disabled		0.3		



6.6 Typical Characteristics

at $T_A = 25^{\circ}C$, $V_S = \pm 42.5$ V, and $V_{CM} = V_{OUT}$ = mid-supply (unless otherwise noted)





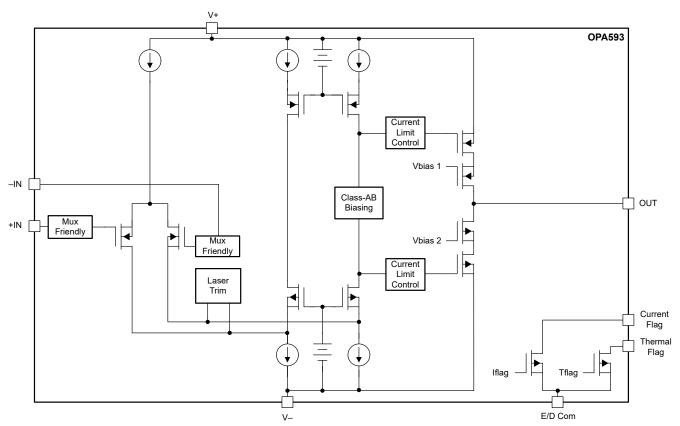
7 Detailed Description

7.1 Overview

The OPA593 is a high-voltage (85 V), power operational amplifier (op amp) with a high output current drive of 250 mA. The device features a current limit with an accuracy of \leq 5% when the output current is greater than 50 mA. The current limit helps protect the system in the event of an output short to ground. Additionally, the device has two flags that indicate an overcurrent fault condition (beyond the configured limit) and an overtemperature fault condition (when the output stage shuts down to prevent damage to the device). Lastly, the output can be disabled to save system power and minimize thermal dissipation.

The unity-gain stable OPA593 has no phase inversion, a common-mode voltage range that includes the negative rail, a rail-to-rail output, and high dc precision. This device also has a wide signal range, 10 MHz of gain bandwidth, and high output current. All these features make the OPA593 an excellent choice as an output driver for a device under test (DUT) in automated test equipment (ATE) systems, or for signal processing in industrial systems using signals greater than 36 V.

7.2 Functional Block Diagram





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7.3 Feature Description

7.3.1 Current Limit

The OPA593 has a high-accuracy, externally programmable current limit that has a $\pm 5\%$ tolerance for output currents ≥ 50 mA. The current limit is set through the ILIMIT pin and is programmable from 10 mA to 250 mA (typical). A resistor can be used to limit the current to a fixed value or a digital-to-analog converter (DAC) can be used to vary the current limit during operation. Figure 7-1 shows a simplified diagram of the current-limit mirror configurations, as well as common resistor or DAC settings and the respective output current limit.

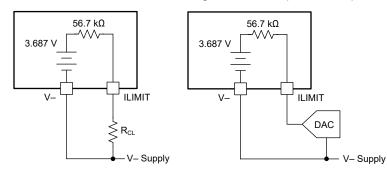


Figure 7-1. OPA593 Internal Current Limit Configurations

The most common configuration is to set the current limit using a resistor (R_{CL}) connected between the ILIMIT pin and the negative supply (V–). With this configuration, Equation 1 and Equation 2 are used to calculate the current limit based on the external resistor value or the resistor needed given the desired current limit value:

$$I_{LIMIT} = \frac{3.687 V * 4000}{56.7 k\Omega + R_{CL}}$$
(1)
$$R_{CL} = \frac{3.687 V * 4000}{I_{LIMIT} - 56.7 k\Omega}$$
(2)

An alternative to fixing the current limit to a single value using an external resistor is to use a DAC, which enables a variable current limit.

CAUTION

With this configuration, the output of the DAC must not exceed the ILIMIT specification in Section 6.1 to avoid reverse biasing the internal current limit circuitry and potentially damaging the device.

Use Equation 3 to set the current limit when a DAC is used (V_{LIMIT} = DAC output voltage):

$$V_{LIMIT} = 3.687 V - \frac{I_{LIMIT} * 56.7 k\Omega}{4000}$$

Several nominal current limit values along with their respective external resistor values and DAC output voltages are listed in Table 7-1.

OUTPUT CURRENT LIMIT (mA)	RESISTOR (Ω)	DAC VOLTAGE (V)			
50	237	2.98			
100	90.9	2.27			
200	16.9	0.85			

Table 7-1. Nominal Current-Limit Values

(3)



The current limit of the OPA593 has a $\pm 10\%$ tolerance for output currents between 25 mA and 50 mA, and is $\pm 5\%$ accurate for currents ≥ 50 mA. Any resistor or DAC tolerances add to the OPA593 tolerance, so take care when selecting the external components to make sure and provide the desired system level accuracy. A correlation between the ideal or calculated output current limit and the actual current limit as measured on the OPA593 is shown in Figure 7-2.

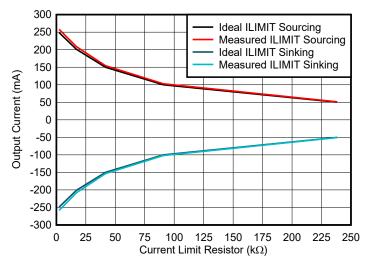


Figure 7-2. Output Current vs Current-Limit Resistor Configuration

7.3.2 Overcurrent Flag

The OPA593 features an overcurrent flag to indicate a condition where the output current draw attempts to exceed the limit configured through the ILIMIT pin, such as in a output short to ground fault condition. In such a situation, the internal current limit of the amplifier limits the output current to the configured value and the flag trips. This flag is an open-drain output designed to connect to standard low-voltage logic circuitry, such as a microcontroller (MCU).

7.3.3 Overtemperature Flag

The OPA593 features an internal thermal shutdown feature. The op amp output stage disables when the junction temperature reaches 170°C. After the junction temperature cools to 150°C, the output stage is enabled, and the op amp resumes normal operation. In the event of an overtemperature condition a thermal flag trips. This flag is an open-drain output designed to connect to standard low-voltage logic circuitry, such as an MCU.



7.3.4 Output Enable and Disable

The OPA593 incorporates an enable and disable feature that uses the E/D pin to disable the output stage of the amplifier, which lowers the power consumption of the op amp and switches the output to a high-impedance state.

The E/D pin is referenced to the E/D Com pin. If left floating, the E/D pin is internally pulled up to enable the device. If externally controlled, the E/D pin must be supplied with a voltage between 2.5 V and 5 V greater than the E/D Com pin voltage. Even though the OPA593 output is enabled with a floating E/D pin, a moderately fast, negative-going signal capacitively coupled to the E/D pin can overpower the internal pullup and cause device shutdown. If the enable function is not used, a conservative and recommended approach is to connect E/D through a 30-pF capacitor to a low-impedance source. Another alternative is to connect an external current source from V+ (positive supply) that is sufficient to hold the enable level greater than the shutdown threshold. Figure 7-3 shows a circuit that connects E/D com.

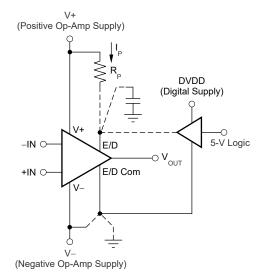


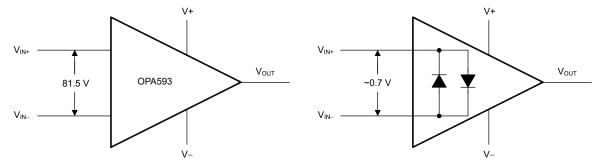
Figure 7-3. E/D and E/D Com

When the E/D pin is dropped to a voltage between 0 V and 0.65 V greater than the E/D Com pin voltage, the output of the OPA593 is disabled. Because the inputs are still active, an input signal might be passed to the output of the amplifier, despite being in a high-output-impedance state. The voltage at the amplifier output is reduced because of a drop across this output impedance, and may appear distorted compared to a normal operation output.



7.3.5 Mux-Friendly Inputs

The OPA593 uses a unique input architecture to eliminate the need for input protection diodes but still provides robust input protection under transient conditions. Conventional input diode protection schemes shown in Figure 7-4 can be activated by fast transient step responses and can introduce signal distortion and settling time delays because of alternate current paths, as shown in Figure 7-5. For low-gain circuits, these fast-ramping input signals forward-bias back-to-back diodes that cause an increase in input current, resulting in extended settling time.



OPA593 Provides Full 81.5-V Differential Input Range

Conventional Input Protection Limits Differential Input Range



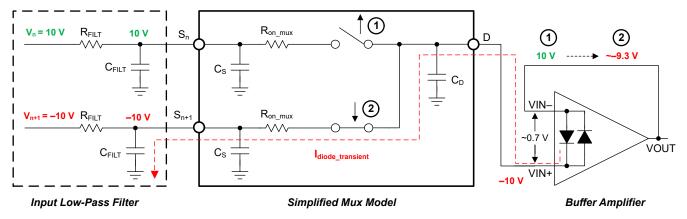


Figure 7-5. Back-to-Back Diodes Create Settling Issues

The OPA593 a true high-impedance differential input capability for high-voltage applications. This patented input protection architecture does not introduce additional signal distortion or delayed settling time, making this device an excellent choice for multichannel, high-switched, input applications. The OPA593 tolerates a maximum differential swing (voltage between inverting and noninverting pins of the op amp) of up to 85 V, making this device a great choice for use as a comparator or in applications with fast-ramping or switched input signals.

7.4 Device Functional Modes

The OPA593 has two modes of operation. The first mode is normal operation where the amplifier is enabled, either by supply a voltage to the enable-disable (E/D) pin that is between 2.5 V and 5 V greater than the E/D Com pin. The second mode of operation is a lower-power, disabled state where the E/D pin is driven between 0 V and 0.65 V greater than the E/D Com pin. In this state, the amplifier output is disabled and enters a high output impedance state.



8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The OPA593 is a high-voltage, high output current op amp. The device is capable of operating with supplies as low as ±5 V (10 V) and as high as ±42.5 V (85 V), with an output current up to 250 mA and an internal current limit with an accuracy of up to ±5%. Thanks to the small size, high operating voltage range, output current, and high dc precision, the device is designed for operating as a high gain stage, driving heavy loads and conditional large signals. The additional features of the OPA593, including the current limit, overcurrent, and overtemperature flags, thermal protection, output disable and mux-friendly inputs, help the device protect both the op amp and the system from potential damage due to various fault conditions.

8.2 Typical Application

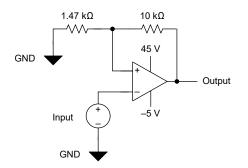


Figure 8-1. Output Driver Configured With a Gain of 8

8.2.1 Design Requirements

The OPA593 is designed for use as an output driver stage with gain thanks to the wide supply voltage and high output current with programmable current limit. These features combined with the small size of the DNT package (4 mm x 4 mm) makes this device a great choice for high-channel density systems such as semiconductor test and manufacturing platforms where many channels may be present. In this design, the OPA593 is configured for a gain of 8. A small negative supply is provided so that if the application requires a small output voltage, such as in the case of a device under test (DUT) continuity check, the amplifier is able to provide the output without being limited by the negative rail (that is, saturating the output).

Table 8-1. Design Parameters								
PARAMETER	VALUE							
Supply voltage	+45 V, –5 V							
Input voltage	0 V to 5 V							
Output voltage	0 V to 40 V							
System gain	8							
Output current	Up to 250 mA							

Table 8-1. D	esign Parameters
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8.2.2 Detailed Design Procedure

In this design example, the OPA593 is configured as both a gain and output driver stage. The input signal to the amplifier is 0 V to 5 V and the device is configured with a positive gain of 8. This configuration results in an output voltage of 0 V to 40 V. The supply voltages are selected to provide adequate headroom so that the amplifier can sink or source up to 250 mA without slamming the output into the rail, while minimizing the swing from the supply to the output to minimize the thermal dissipation of the device.

This simple design example is common in many systems using a DAC to provide the input signal and require a wide output signal with high output current. Such systems include test & measurement platforms and power supplies.

Figure 8-2 shows the input and output signal of this OPA593 circuit.

8.2.3 Application Curve

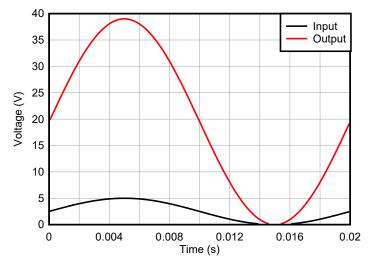


Figure 8-2. OPA593 Output Driver Circuit, Input and Output Signals



9 Power Supply Recommendations

The OPA593 operates from power supplies up to ± 42.5 V, or a total of 85 V, with excellent performance. Most behavior remains unchanged throughout the full operating voltage range. A power-supply bypass capacitor of at least 0.1 μ F is required for proper operation. Make sure that the capacitor voltage rating is suitable for the high voltage across the full operating temperature range. Parameters that vary significantly with operating voltage are shown in Section 6.6.

Some applications do not require an equal positive and negative output voltage swing. Power-supply voltages do not have to be equal. The OPA593 operates with as little as 10 V between the supplies, and with up to 85 V between the supplies.

10 Layout

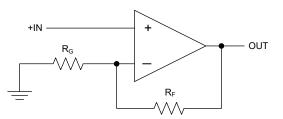
10.1 Layout Guidelines

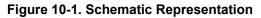
During the surface-mount solder operation (when the leads are being soldered), the thermal pad must be soldered to a copper area underneath the package. Through the use of thermal paths within this copper area, heat is conducted away from the package into either a ground plane or other heat-dissipating device. Always solder the thermal pad to the PCB, even with applications that have low power dissipation. Follow these steps to attach the device to the PCB:

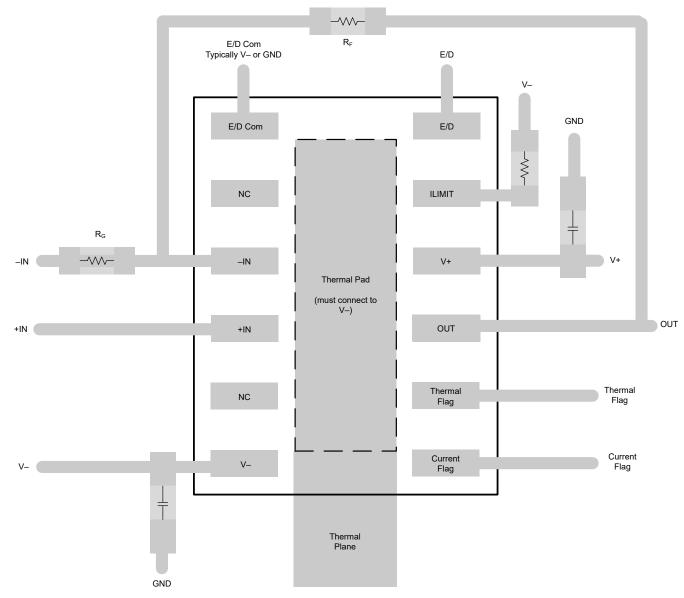
- 1. Connect the thermal pad to the most negative supply voltage on the device, V-.
- 2. Prepare the PCB with a top-side etch pattern. There must be etching for the leads, as well as etching for the thermal pad.
- 3. Thermal vias improve heat dissipation, but are not required. The thermal pad can connect to the PCB using an area equal to the pad size with no vias, but must be externally connected to V–.
- 4. Place recommended holes in the area of the thermal pad. Recommended thermal land size and thermal via patterns for the SON-12 DNT package are shown in the thermal land pattern mechanical drawing appended at the end of this document. Keep the holes small, so that solder wicking through the holes is not a problem during reflow. Use a 0.2-mm size via with a minimum of five connected directly below the thermal pad.
- 5. Additional vias can be placed anywhere along the thermal plane outside of the thermal pad area. These vias help dissipate the heat generated by the OPA593 device. These additional vias may be larger than the vias directly under the thermal pad because they are not in the thermal pad area to be soldered; thus, wicking is not a problem.
- 6. Connect all holes to the internal power plane of the correct voltage potential, V-.
- 7. When connecting these holes to the plane, do not use the typical web or spoke via connection methodology. Web connections have a high thermal resistance connection that is useful for slowing the heat transfer during soldering operations, making the soldering of vias that have plane connections easier. In this application, however, low thermal resistance is desired for the most efficient heat transfer. Therefore, the holes under the OPA593 WSON package must make the connections to the internal plane with a complete connection around the entire circumference of the plated-through hole.
- 8. The top-side solder mask must leave the pins of the package and the thermal pad area exposed. The bottom-side solder mask must cover the holes of the thermal pad area. This masking prevents solder from being pulled away from the thermal pad area during the reflow process.
- 9. Apply solder paste to the exposed thermal pad area and all of the device pins.
- 10. With these preparatory steps in place, simply place the device in position, and run through the solder reflow operation as with any standard surface-mount component.



10.2 Layout Example











11 Device and Documentation Support 11.1 Device Support

11.1.1 Development Support

11.1.1.1 PSpice[®] for TI

PSpice[®] for TI is a design and simulation environment that helps evaluate performance of analog circuits. Create subsystem designs and prototype solutions before committing to layout and fabrication, reducing development cost and time to market.

11.1.1.2 TINA-TI™ Simulation Software (Free Download)

TINA[™] is a simple, powerful, and easy-to-use circuit simulation program based on a SPICE engine. TINA-TI[™] is a free, fully-functional version of the TINA software, preloaded with a library of macro models in addition to a range of both passive and active models. TINA-TI provides all the conventional dc, transient, and frequency domain analysis of SPICE, as well as additional design capabilities.

Available as a free download from the Analog eLab Design Center, TINA-TI offers extensive post-processing capability that allows users to format results in a variety of ways. Virtual instruments offer the ability to select input waveforms and probe circuit nodes, voltages, and waveforms, creating a dynamic quick-start tool.

Note

These files require that either the TINA software (from DesignSoft[™]) or TINA-TI software be installed. Download the free TINA-TI software from the TINA-TI folder at http://www.ti.com/tool/tina-ti.

11.1.1.3 TI Precision Designs

TI Precision Designs, available online at , are analog solutions created by TI's precision analog applications experts and offer the theory of operation, component selection, simulation, complete PCB schematic and layout, bill of materials, and measured performance of many useful circuits.

11.2 Documentation Support

11.2.1 Related Documentation

- Texas Instruments, Circuit Board Layout Techniques
- Texas Instruments, Op Amps for Everyone

11.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.4 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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11.5 Trademarks

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11.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.7 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

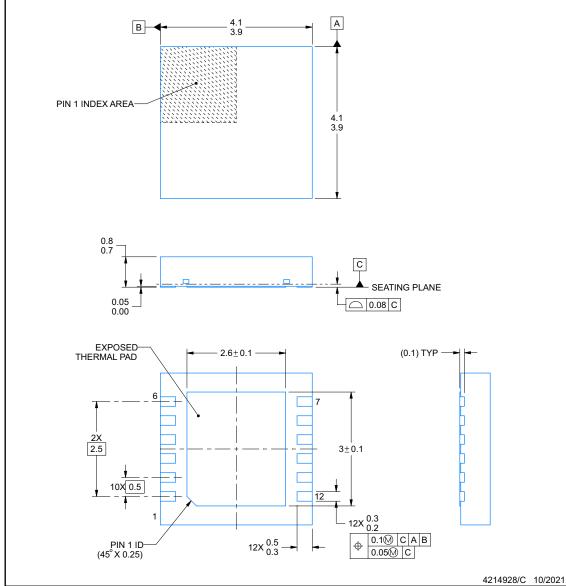
The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGE OUTLINE

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
This drawing is subject to change without notice.
The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



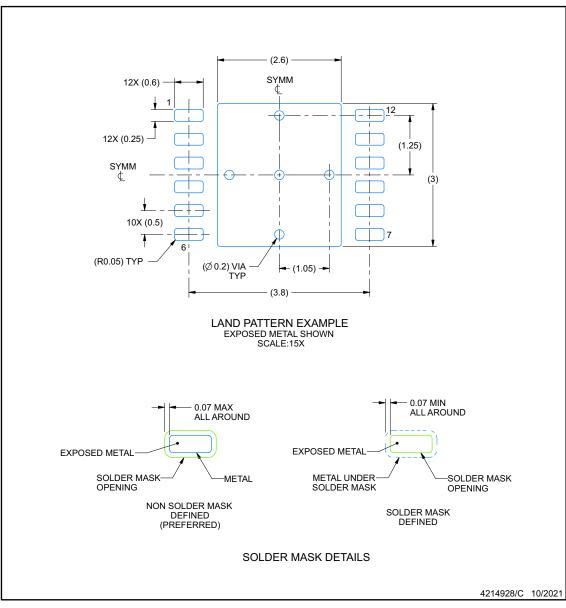
Product Folder Links: OPA593



EXAMPLE BOARD LAYOUT

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



ADVANCE INFORMATION

NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



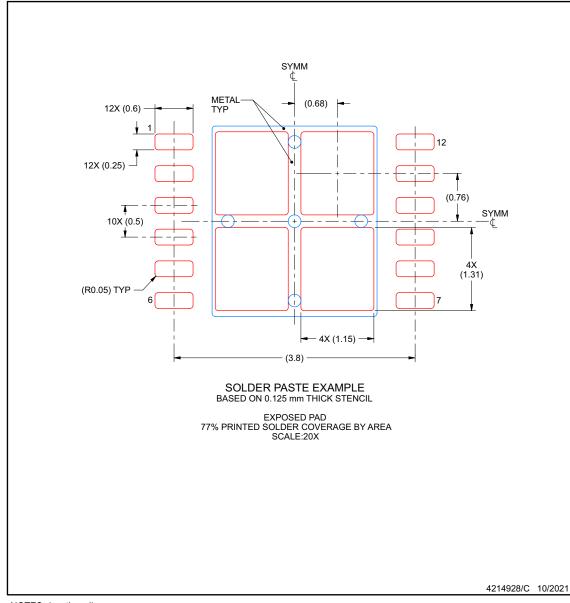


EXAMPLE STENCIL DESIGN

DNT0012B

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.





PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	e Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
XOPA593DNTR	ACTIVE	WSON	DNT	12	5000	TBD	Call TI	Call TI	-40 to 125		Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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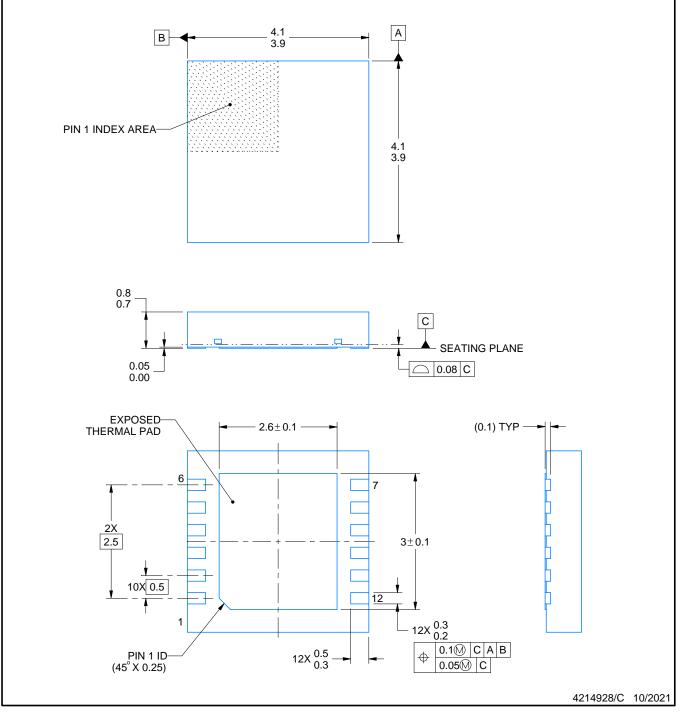
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PACKAGE OUTLINE

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

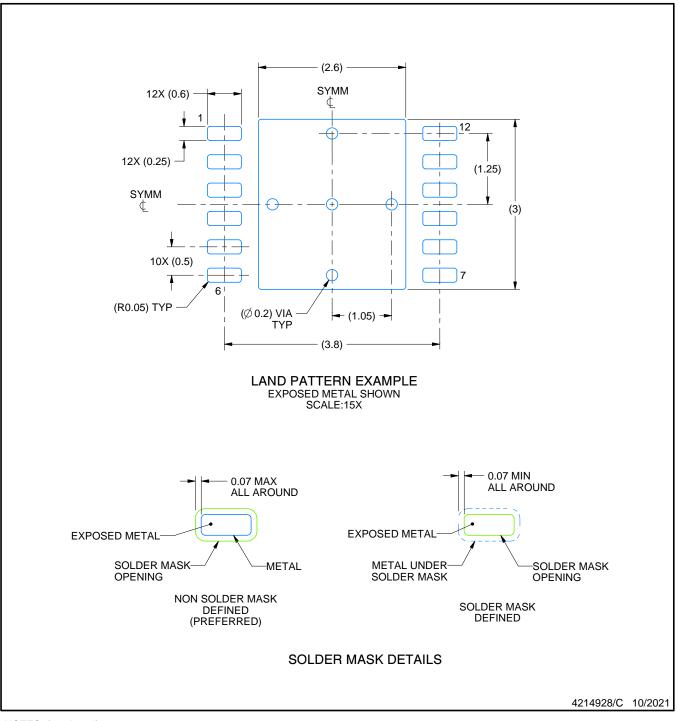
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.2. This drawing is subject to change without notice.3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



EXAMPLE BOARD LAYOUT

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

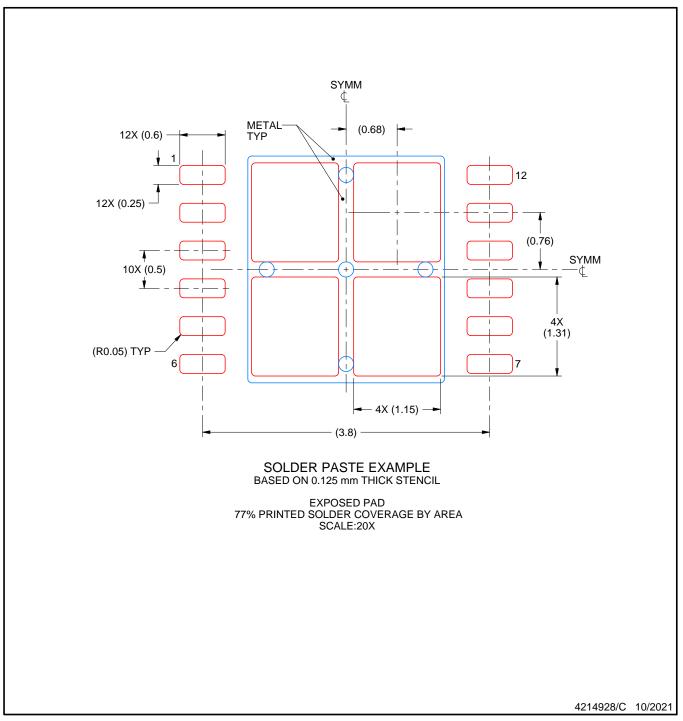
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



EXAMPLE STENCIL DESIGN

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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